

|   | Type | L # | Hits | Search Text      | DBs  | Time Stamp          |
|---|------|-----|------|------------------|--|---------------------|
| 1 | IS&R | L1  | 304  | (257/428) .CCLS. | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>12:11 |
| 2 | IS&R | L2  | 853  | (257/659) .CCLS. | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>12:58 |
| 3 | IS&R | L7  | 281  | (257/660) .CCLS. | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>13:49 |

|   | Type | L # | Hits        | Search Text                           | DBs  | Time Stamp          |
|---|------|-----|-------------|---------------------------------------|--|---------------------|
| 1 | BRS  | L1  | 4241        | bare adj chip                         | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:49 |
| 2 | BRS  | L2  | 748421      | (integrated adj circuit) or IC        | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:49 |
| 3 | BRS  | L3  | 237538      | (back adj surface) or (back adj side) | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:49 |
| 4 | BRS  | L4  | 1933        | magnetic adj loss                     | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:49 |
| 5 | BRS  | L5  | 196283<br>4 | substrate or wafer                    | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:49 |

|    | Type | L # | Hits        | Search Text  | DBs  | Time Stamp          |
|----|------|-----|-------------|--|--|---------------------|
| 6  | BRS  | L6  | 654         | (bare adj chip) near4<br>((integrated adj circuit)<br>or IC)   | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:49 |
| 7  | BRS  | L8  | 1           | ((bare adj chip) near4<br>((integrated adj circuit)<br>or IC) ) same (magnetic adj<br>loss)                              | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:49 |
| 8  | BRS  | L9  | 1           | ((bare adj chip) near4<br>((integrated adj circuit)<br>or IC) ) and (magnetic adj<br>loss)                               | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:49 |
| 9  | BRS  | L10 | 125219<br>7 | magnetic   | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:49 |
| 10 | BRS  | L12 | 91862       | magnetic near4 (fe or co or<br>ni or f or n or o or cobalt<br>or nickle or iron or<br>fluorine or nitrogen or<br>oxygen) | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:49 |

|    | Type | L # | Hits        | Search Text  | DBs  | Time Stamp          |
|----|------|-----|-------------|--|--|---------------------|
| 11 | BRS  | L13 | 1           | (bare adj chip) near8<br>(magnetic near4 (fe or co<br>or ni or f or n or o or<br>cobalt or nickle or iron or<br>fluorine or nitrogen or<br>oxygen))  | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:49 |
| 12 | BRS  | L15 | 158175<br>8 | (integrated adj circuit) or<br>IC or chip or die or dice   | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:50 |
| 13 | BRS  | L16 | 49153       | magnetic same ((integrated<br>adj circuit) or IC or chip<br>or die or dice)  | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:50 |
| 14 | BRS  | L17 | 1394        | (magnetic near4 (fe or co<br>or ni or f or n or o or<br>cobalt or nickle or iron or<br>fluorine or nitrogen or<br>oxygen)) same ((integrated<br>adj circuit) or IC or chip<br>or die or dice)  | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:50 |
| 15 | BRS  | L18 | 0           | ((magnetic near4 (fe or co<br>or ni or f or n or o or<br>cobalt or nickle or iron or<br>fluorine or nitrogen or<br>oxygen)) same ((integrated<br>adj circuit) or IC or chip<br>or die or dice)) same<br>(substrate or wafer)) same<br>((back adj surface) or<br>(back adj side)) | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:50 |

|    | Type | L # | Hits | Search Text   | DBs  | Time Stamp          |
|----|------|-----|------|---|--|---------------------|
| 16 | BRS  | L21 | 1773 | ((integrated adj circuit) or IC) near8 ((back adj surface) or (back adj side))  | USPAT;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:50 |
| 17 | BRS  | L22 | 0    | ((integrated adj circuit) or IC) near8 ((back adj surface) or (back adj side))) near8 (magnetic near4 (fe or co or ni or f or n or o or cobalt or nickle or iron or fluorine or nitrogen or oxygen))  | USPAT;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:50 |
| 18 | BRS  | L23 | 0    | ((integrated adj circuit) or IC) near8 ((back adj surface) or (back adj side))) near16 (magnetic near4 (fe or co or ni or f or n or o or cobalt or nickle or iron or fluorine or nitrogen or oxygen)) | USPAT;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:50 |
| 19 | BRS  | L28 | 2329 | magnetic near4 ((back adj surface) or (back adj side))  | USPAT;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 20 | BRS  | L29 | 246  | (magnetic near4 ((back adj surface) or (back adj side)) ) near8 (substrate or wafer)  | USPAT;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |

|    | Type | L # | Hits  | Search Text                                      | DBs  | Time Stamp          |
|----|------|-----|-------|--|--|---------------------|
| 21 | BRS  | L31 | 0     | fe72a11o17                                       | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 22 | BRS  | L32 | 26    | fealo  | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 23 | BRS  | L33 | 47    | magnetic adj loss and<br>semiconductor and die   | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 24 | BRS  | L34 | 12493 | token.as.  | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 25 | BRS  | L35 | 12    | semiconductor adj wafer and<br>magnetic adj loss | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |

|    | Type | L # | Hits | Search Text  | DBs  | Time Stamp          |
|----|------|-----|------|--|--|---------------------|
| 26 | BRS  | L36 | 14   | semiconductor adj wafer and<br>tokin.as.   | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 27 | BRS  | L37 | 19   | 3963489.uref.  | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 28 | BRS  | L38 | 43   | semiconductor adj die and<br>magnetic adj material   | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 29 | BRS  | L7  | 1    | ((bare adj chip) near4<br>((integrated adj circuit)<br>or IC) ) near8 (magnetic<br>adj loss) | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 30 | BRS  | L11 | 13   | ((bare adj chip) near4<br>((integrated adj circuit)<br>or IC) ) near8 magnetic               | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |

|    | Type | L # | Hits | Search Text   | DBs  | Time Stamp          |
|----|------|-----|------|---|--|---------------------|
| 31 | BRS  | L14 | 2    | (bare adj chip) same<br>(magnetic near4 (fe or co<br>or ni or f or n or o or<br>cobalt or nickle or iron or<br>fluorine or nitrogen or<br>oxygen))  | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 32 | BRS  | L19 | 225  | ((magnetic near4 (fe or co<br>or ni or f or n or o or<br>cobalt or nickle or iron or<br>fluorine or nitrogen or<br>oxygen)) same ((integrated<br>adj circuit) or IC or chip<br>or die or dice)) same<br>(substrate or wafer)  | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 33 | BRS  | L20 | 13   | ((magnetic near4 (fe or co<br>or ni or f or n or o or<br>cobalt or nickle or iron or<br>fluorine or nitrogen or<br>oxygen)) same ((integrated<br>adj circuit) or IC or chip<br>or die or dice)) same<br>(substrate or wafer)) and<br>((back adj surface) or<br>(back adj side)) | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 34 | BRS  | L24 | 2    | ((integrated adj circuit)<br>or IC) near8 ((back adj<br>surface) or (back adj<br>side))) same (magnetic<br>near4 (fe or co or ni or f<br>or n or o or cobalt or<br>nickle or iron or fluorine<br>or nitrogen or oxygen))  | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 35 | BRS  | L25 | 40   | ((back adj surface) or<br>(back adj side)) same<br>(substrate or wafer) same<br>((integrated adj circuit)<br>or IC) same magnetic   | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |



|    | Type | L # | Hits | Search Text   | DBs  | Time Stamp          |
|----|------|-----|------|---|--|---------------------|
| 36 | BRS  | L26 | 2    | (magnetic adj loss) near4<br>((back adj surface) or<br>(back adj side))   | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 37 | BRS  | L27 | 6    | (magnetic adj loss) same<br>((back adj surface) or<br>(back adj side))  | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 38 | BRS  | L30 | 9    | ((magnetic near4 ((back adj<br>surface) or (back adj<br>side)) ) near8 (substrate<br>or wafer)) same<br>((integrated adj circuit)<br>or IC) | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 39 | IS&R | L40 | 2    | ("6653573").PN.   | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:51 |
| 40 | BRS  | L41 | 7    | ("5435903"   "5493074"  <br>"5639989"   "5738931"  <br>"5966294"   "5998048"  <br>"6208000").PN.  | USPAT  | 2004/05/25<br>08:51 |

|    | Type | L # | Hits  | Search Text                            | DBs  | Time Stamp          |
|----|------|-----|-------|--|--|---------------------|
| 41 | BRS  | L42 | 25    | noise adj suppression and<br>token.as. | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:56 |
| 42 | BRS  | L43 | 27601 | 3 near8 5                              | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:57 |
| 43 | BRS  | L44 | 0     | 43 same 32                             | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:57 |
| 44 | BRS  | L45 | 1     | 43 same (magnetic adj loss)            | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:58 |
| 45 | BRS  | L46 | 1     | 43 and (M-X-Y or MXY)                  | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:58 |

|    | Type | L # | Hits | Search Text           | DBs  | Time Stamp          |
|----|------|-----|------|-----------------------|--|---------------------|
| 46 | BRS  | L47 | 338  | granular adj magnetic | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:59 |
| 47 | BRS  | L48 | 98   | 47 same 5             | USPAT<br>;<br>US-PG<br>PUB;<br>EPO;<br>JPO;<br>DERWE<br>NT;<br>IBM_T<br>DB | 2004/05/25<br>08:59 |